## Notice of References Cited

Application/Control No.	Applicant(s)/Pat Reexamination LEE ET AL.			
Examiner	Art Unit			
Leigh McKane	1744	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,444,103	08-1995	Tabata et al.	522/5
6.	В	US-6,203,551	03-2001	Wu, Steven Z.	606/108
	O.	US-			
	D	US-	8		
	E	US-			
	F	US-			
	G <sub>0</sub>	US-	,	·	
	Ή	US-			
- 1		US-			
	J	US-			
	К	US-	1		
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 490472A2	06-1992	EPO	RANGWALLA et al	
	0	WO 99/13924A2	03-1999	WIPO	LEE et al	
L	Р					
	σ					
	R					
	ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.